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# Spirobifluorene with an asymmetric fluorenylcarbазоlamine electron-donor as the hole transport material increases thermostability and efficiency of perovskite solar cells†

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The efficiency of perovskite solar cells utilizing spiro-OMeTAD as the hole transport material has been persistently enhanced, attaining the current 25.7%. However, these high-efficiency cells are unable to withstand the harsh heat at 85 °C. In this report, we present a spirobifluorene based hole transport material with highly asymmetric fluorenylcarbазоlamine as the electron-donor, denoted as SBF-FC. Compared to spiro-OMeTAD, SBF-FC exhibits a comparable HOMO energy level, but the glass transition temperature is almost twice as high. The composite produced by blending SBF-FC and 4-*tert*-butylpyridinium bis(trifluoromethanesulfonyl)imide at an 85:15 weight ratio demonstrates a room temperature conductivity of 49  $\mu\text{S cm}^{-1}$  while retaining a high glass transition temperature of 176 °C. Importantly, the SBF-FC based hole transport layer, deposited onto the surface of a FAPbI<sub>3</sub> thin film, exhibits a more uniform morphology and remarkably improved 85 °C durability, effectively suppressing the corrosion and decomposition of the perovskite film. By utilizing the SBF-FC based hole transport layer, we demonstrate perovskite solar cells achieving an average initial efficiency of 24.5% and long-term thermostability at 85 °C.

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## Broad context

To achieve efficient and stable PSCs, the selection of electron and hole transport layers is crucial, in addition to the perovskite light-absorbing layer. When utilizing oxide electron transport layers such as TiO<sub>2</sub> or SnO<sub>2</sub>, it is essential to carefully select a hole transport layer (HTL) that exhibits specific fundamental characteristics. First, the HTL should be able to form a uniform and sufficiently thick film on the perovskite surface to prevent micro-scale contact between the metal electrode and the perovskite, which can trigger rapid charge recombination. Second, the HTL should have a HOMO energy level higher than the valence band maximum of the perovskite to facilitate swift injection of holes from the excited-state perovskite. Third, the HTL should possess appropriate hole density, mobility, and conductivity to minimize the internal resistance of the solar cell and slow down charge recombination at the interface between the perovskite and the HTL. Fourth, the HTL should maintain its morphology even at elevated temperatures. Finally, the HTL should effectively control the migration of both intrinsic and extrinsic species.

## 1 Introduction

Lead halide perovskites are a class of affordable semiconductor materials that can be deposited as defect-tolerant polycrystalline thin films using solution-based techniques.<sup>1</sup> These

remarkable films exhibit excellent properties for harvesting solar light and transporting charge carriers.<sup>2</sup> Notably, methylammonium lead triiodide,<sup>3</sup> formamidinium lead triiodide (FAPbI<sub>3</sub>),<sup>4</sup> cesium lead triiodide,<sup>5</sup> and the related alloyed perovskites<sup>6</sup> can all serve as light-harvesting active layers in solar cells, enabling efficient conversion of solar energy into electrical energy. Recent years have witnessed a surge in the exploitation of FAPbI<sub>3</sub> in perovskite solar cells (PSCs),<sup>4,7,8</sup> due to its broad spectral response and relatively high thermal decomposition temperature. With consecutive advancements in processing methods that control the composition, crystallinity, grain size, and morphology of perovskite thin films,

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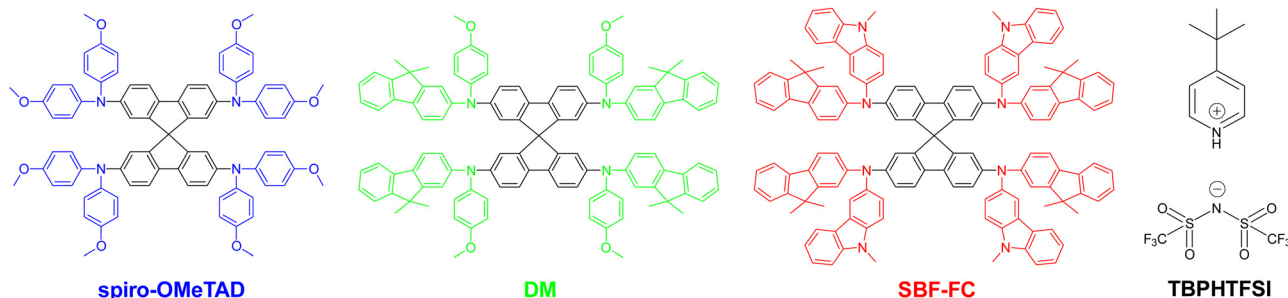


Fig. 1 Molecular structures of the hole transport materials spiro-OMeTAD, DM, and SBF-FC as well as the oxygen doping auxiliary reagent TBPHTFSI.

laboratory-scale single-junction PSCs have surpassed power conversion efficiencies (PCE) of 25% by using spiro-OMeTAD as the hole transport material (HTM), as depicted in Fig. 1. However, the thermal stress at 85 °C exceeds the tolerance of these exceptionally efficient cells. Although using some HTMs including molecular semiconductors with high glass transition temperatures<sup>9–12</sup> or polymeric semiconductors<sup>13,14</sup> can enable the fabrication of PSCs with 85 °C thermostability, their initial PCEs are not yet sufficiently high. So far, the fabrication of a thermally durable (85 °C) PSC with an efficiency greater than 24% remains a significant challenge.

Spiro-OMeTAD comprising a 9,9'-spirobifluorene (SBF) core and four bis(4-methoxyphenyl)amine (OMeDPA) electron-donors was first reported by Salbeck *et al.* in 1997.<sup>15</sup> The structural origin of this material is traced back to the early 20th century when OMeDPA was first synthesized by Wieland *et al.* in 1910<sup>16</sup> and SBF was synthesized by Clarkson and Gomberg in 1930.<sup>17</sup> Subsequently, doping spiro-OMeTAD with an oxidizing agent during the solution deposition of an amorphous film significantly improved the efficiency of solid-state dye-sensitized solar cells.<sup>18</sup> Since 2012, the PCE record for PSCs has been repeatedly broken by the use of spiro-OMeTAD. We contend that these advancements stem not only from the commercial availability, but also from the appropriate energy levels, hole density, hole mobility, and morphology of a doped hole transport layer (HTL) of spiro-OMeTAD, as well as its sluggish charge recombination with perovskites. However, spiro-OMeTAD has a glass transition temperature ( $T_g$ ) of marginally higher than 120 °C, which typically decreases upon doping, leading to crystallization and cracking of the HTL when exposed to a prolonged heating period at 85 °C.<sup>19–21</sup> In our previous study, we have found that the degradation in the morphology of a spiro-OMeTAD based HTL ultimately reduces the efficiency of PSCs significantly.<sup>21</sup> While efforts have been made to develop new HTMs that incorporate SBF and other electron-donors, their overall quality factors including film-forming properties, energy levels, hole conduction, and glass transition are not entirely satisfactory.<sup>22–28</sup> For instance, Jeon *et al.*<sup>29</sup> introduced a novel SBF based HTM with the electron-donor methoxyphenylfluorenamine for 60 °C thermostable perovskite solar cells, denoted as DM and is illustrated in Fig. 1. DM displays an elevated glass transition temperature of 161 °C but a reduced hole conduction relative to spiro-OMeTAD.

In this report, we present an SBF based HTM, denoted as SBF-FC (see Fig. 1), which is characterized by the electron-donor fluorenylcarbazolamine (FC). SBF-FC demonstrates a substantially higher  $T_g$  and superior film-forming properties compared to spiro-OMeTAD. Furthermore, under similar material processing conditions, SBF-FC exhibits enhanced hole mobility and conductivity. The utilization of SBF-FC as the HTL in PSCs results in average cell efficiency of *ca.* 24.5%, and the cells demonstrate good long-term thermostability at 85 °C. Our findings demonstrate that SBF-FC is a promising candidate for high-performance PSCs.

## 2 Results and discussion

### 2.1 Photoinduced charge separation

In this study, we employed a FAPbI<sub>3</sub> thin film containing a small admixture of (PbI<sub>2</sub>)<sub>2</sub>RbCl<sup>8</sup> as the light-absorbing layer. We first measured the photoluminescence lifetimes ( $\tau$ ) of FAPbI<sub>3</sub> on glass and SnO<sub>2</sub> substrates, which were found to be 3.6  $\mu$ s and 192 ns, respectively (see Fig. S1 and Table S1, ESI<sup>†</sup>). The difference in  $\tau$  values indicates that SnO<sub>2</sub> can extract electrons from photoexcited FAPbI<sub>3</sub>. However, the photoinduced electron extraction yield by SnO<sub>2</sub> was only 95%, likely due to the small conduction band offset between the two semiconductors. Moreover, we measured the  $\tau$  of HTL-covered FAPbI<sub>3</sub> and found it to be 32.4 ns for spiro-OMeTAD and 40.3 ns for SBF-FC. Despite the higher HOMO energy level and lower reorganization energy (see Table S2, ESI<sup>†</sup>), SBF-FC exhibits slower hole extraction than spiro-OMeTAD. This might be due to its weaker electronic wave function coupling with the perovskite, resulting from its less HOMO distribution on certain edge segments (see Fig. S2, ESI<sup>†</sup>). Nonetheless, SBF-FC still exhibits a hole extraction yield approaching 100% resulting from the photoexcited FAPbI<sub>3</sub>.

### 2.2 Hole conduction

The series resistance of PSCs, which includes the resistance of the HTL, has a significant impact on the PCE.<sup>30</sup> Apart from thickness, the resistivity of the HTL is also critical in determining its resistance. We conducted measurements using gold interdigital electrodes with a channel width of 10  $\mu$ m to determine the direct-current conductivity ( $\sigma$ ), *i.e.*, the reciprocal of resistivity. Our results indicate that SBF-FC has an average  $\sigma$

of  $0.28 \mu\text{S cm}^{-1}$  at  $25^\circ\text{C}$ , which is more than twice as high as that of spiro-OMeTAD at  $0.12 \mu\text{S cm}^{-1}$ . To investigate the hole density ( $p$ ) of the pristine HTL, we fabricated a metal-insulator-semiconductor device and obtained the capacitance-voltage curve. Using the Mott-Schottky relationship, we calculated an average  $p$  of  $1.5 \times 10^{17} \text{ cm}^{-3}$  for SBF-FC, which is comparable to that of spiro-OMeTAD at  $1.3 \times 10^{17} \text{ cm}^{-3}$ .

Undoped materials generate charge carriers through thermal excitation,<sup>31</sup> which can be expressed as  $2\text{HTM} = \text{HTM}^+ + \text{HTM}^-$ , where  $\text{HTM}^+$  and  $\text{HTM}^-$  represent cation and anion free radicals of the HTM, respectively. For a HTM with an optical bandgap greater than 2 eV, the  $p$  generated by thermally excited disproportionation is expected to be less than  $10^3 \text{ cm}^{-3}$ , which is at least 14 orders of magnitude lower than the measured value. Hence, we conclude that the HTL with a relatively high HOMO energy level has unintentionally been doped with oxygen from the air,<sup>32,33</sup> even without deliberate doping. If we exclude acidic gases from the air, the chemical reaction can be represented by  $2\text{HTM} + \text{O}_2 = (\text{HTM}^+)_2\text{O}_2^{2-}$ . The  $p$  generated by air oxidation doping is greater with a higher HOMO energy level of the HTM. We determined the hole mobility ( $\mu_p$ ) of the HTL using the formula  $\mu_p = \sigma/qp$  (where  $q$  represents the elementary charge), which yielded a value of  $1.2 \times 10^{-5} \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$  for SBF-FC, twice that of spiro-OMeTAD's  $5.8 \times 10^{-6} \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$ .

Next, we aimed to enhance the air oxidation doping of the HTL by incorporating 4-*tert*-butylpyridinium bis(trifluoromethanesulfonyl)imide (TBPHTFSI, Fig. 1), as the auxiliary reagent during the film deposition process.<sup>21</sup> It is worth noting that in comparison to the conventional doping auxiliary reagent LiTFSI, TBPHTFSI exhibits less hygroscopicity and greater solubility in typical nonpolar organic solvents. Moreover, it possesses a thermal decomposition temperature exceeding  $200^\circ\text{C}$ . The chemical

reaction involved in this process can be represented by  $2\text{HTM} + \text{O}_2 + 2\text{TBPHTFSI} = 2\text{HTM}^+\text{TFSI}^- + \text{H}_2\text{O}_2 + 2\text{TBP}$ , where  $\text{TBPHTFSI}^+$  is the 4-*tert*-butylpyridinium cation,  $\text{TFSI}^-$  is the bis(trifluoromethanesulfonyl)imide anion, and TBP is 4-*tert*-butylpyridine. Our results show that the  $\sigma$  value at  $25^\circ\text{C}$  of the HTL composed of both HTM and TBPHTFSI, increases exponentially with the increase of the salt content (Fig. 2A). At the 15% weight percentage of TBPHTFSI, the  $\sigma$  values of the composite HTLs are  $30.1 \mu\text{S cm}^{-1}$  for spiro-OMeTAD,  $2.3 \mu\text{S cm}^{-1}$  for DM, and  $48.8 \mu\text{S cm}^{-1}$  for SBF-FC. Moreover, the electron paramagnetic resonance (EPR) measurements demonstrate the gradual strengthening of cationic free radicals with an increase in the TBPHTFSI content (Fig. 2B and C). The  $p$  value of the HTL with TBPHTFSI was reckoned by comparing its EPR quadratic integral with that of a pristine film without TBPHTFSI (Fig. 2D), and it increased linearly with the increase of the salt content (Fig. 2E). Based on the relationship between  $\mu_p$ ,  $\sigma$ , and  $p$ , the  $\mu_p$  value of the TBPHTFSI-containing HTL was calculated and found to gradually increase with an increase in  $p$  (Fig. 2F). At a specified  $p$  value, the  $\mu_p$  value of the HTL exhibits a greater magnitude for SBF-FC when compared to spiro-OMeTAD.

Furthermore, we performed variable temperature conductivity measurements of the HTL and observed that the  $\sigma$  value increases with an increase in temperature (Fig. S3, ESI<sup>†</sup>). The activation energy of hole conduction was then calculated using the Arrhenius formula, which revealed an exponential decrease in the activation energy with the increase of the salt content (Fig. 2G). It can be concluded that the hole density gradually increases with the gradual increase of the TBPHTFSI content, leading to the gradual filling of traps, which in turn reduces the activation energy of hole conduction and increases the hole mobility.<sup>34-37</sup>



Fig. 2 (A) Plots of electrical conductivity ( $\sigma$ ) versus weight percentage (wt%) of TBPHTFSI. (B and C) Electron paramagnetic resonance spectra. Magnetic field strength,  $B$ ; first derivative of absorption intensity,  $dI/dB$ . (D) Quadratic integral of  $dI/dB$ . (E) Hole density ( $p$ ). (F) Plots of hole mobility ( $\mu_p$ ) versus  $p$ . (G) Activation energy ( $E_a$ ). (H) Kinetic Monte Carlo simulated hole mobility ( $\mu_p^{\text{KMC}}$ ).

The kinetic Monte Carlo (KMC) method was further employed to simulate hole transport in amorphous solids.<sup>38</sup> Our results, presented in Fig. 2H, demonstrate that as the  $p$  value increases, so does the simulated hole mobility ( $\mu_p^{\text{KMC}}$ ). Notably, SBF-FC exhibits a higher  $\mu_p^{\text{KMC}}$  value than spiro-OMeTAD when  $p$  is identical. This finding is in agreement with previous experimental measurements. In amorphous molecular semiconductor films, charge carriers are highly localized, and their hopping between neighboring molecules is facilitated by thermal activation. The rate of hole hopping depends on various parameters, including the HOMO energy level difference of the hopping sites ( $\Delta E_{ij}$ ), the transfer integral ( $v_{ij}$ ), the centroid distance ( $d$ ), and the reorganization energy ( $\lambda$ ). To estimate the energetic disorder ( $w$ ), we used a Gaussian function to fit the  $\Delta E_{ij}$  values. As depicted in Fig. 3A and B, the  $w$  value for spiro-OMeTAD is 167 meV, while that for SBF-FC is 142 meV. A smaller  $w$  value is advantageous for hole transport at low  $p$ . Although SBF-FC does not exhibit a conclusive advantage in  $v_{ij}$  (Fig. 3C), its average  $d$  is larger (Fig. 3D), which enhances hole transport. Furthermore, the  $\lambda$  value for spiro-OMeTAD is 172 meV, whereas that for SBF-FC is 155 meV. We attribute the smaller  $\lambda$  value of SBF-FC to the larger conjugated system of its electron-donor.

### 2.3 Glass transition of hole transport materials

In PSCs, the amorphous organic HTL can experience strain and/or crystallization as it approaches its glass transition temperature ( $T_g$ ), resulting in reduced film uniformity, flatness, and the formation of pinholes or cracks that can impair the cell efficiency. We first used differential scanning calorimetry (DSC) to measure the  $T_g^{\text{DSC}}$  of SBF-FC, which was found to be 222 °C, almost 100 °C higher than that of spiro-OMeTAD. This discrepancy in  $T_g^{\text{DSC}}$  is thought to be due to variations in intermolecular interactions. When 15 wt% TBPHTFSI was added, a noticeable plasticization effect was observed, resulting in a significant reduction of approximately 45 °C in  $T_g^{\text{DSC}}$ . Nevertheless, the  $T_g^{\text{DSC}}$  of the SBF-FC composite remained



Fig. 3 (A and B) Distribution profiles of the HOMO energy level difference ( $\Delta E_{ij}$ ). The black solid lines refer to the Gaussian fits to acquire the energetic disorders, being 167 meV for spiro-OMeTAD and 142 meV for SBF-FC. (C and D) Profile of transfer integral ( $v_{ij}$ ) and centroid distance ( $d$ ).



Fig. 4 (A) Correlation between theoretical and experimental glass transition temperatures. (B–E) Plots of the diffusion coefficient ( $D$ ) of species in the 15 wt% TBPHTFSI containing composites as a function of temperature ( $T$ ): (B) TBPH<sup>+</sup> cation; (C) TFSI<sup>-</sup> anion; (D) HI; and (E) H<sub>2</sub>O. (F) Theoretical permeability ( $P$ ) of H<sub>2</sub>O in the composites at room temperature.

impressively high, reaching 176 °C, surpassing that of the spiro-OMeTAD counterpart, which has a  $T_g^{\text{DSC}}$  of only 75 °C. The thermal expansion coefficient of an amorphous solid experiences an abrupt change during glass transition. To determine the theoretical glass transition temperature ( $T_g^{\text{SV}}$ ), we carried out linear fits of specific volume as a function of temperature for high-temperature and low-temperature data obtained through molecular dynamics simulations (Fig. S4, ESI<sup>†</sup>). As illustrated in Fig. 4A, a strong linear relationship exists between  $T_g^{\text{DSC}}$  and  $T_g^{\text{SV}}$ .

### 2.4 Diffusion in the hole transport layer

The doping of organic semiconductor materials with p-type and n-type impurities results in the presence of anions and cations, which serve to maintain electrostatic balance.<sup>39–41</sup> In PSCs, changes in device parameters can occur due to the diffusion of certain components in the perovskite layer and HTL, as well as ion drift caused by the built-in electric field. For example, the migration of iodide anions into the HTL can reduce doping. Furthermore, the durability of PSCs can be compromised by the slow decomposition of the perovskite under conditions of high temperature and humidity. Thus, it is essential to control the infiltration of environmental moisture and the escape of volatile perovskite components through the HTL.<sup>42,43</sup> Therefore, we employed molecular dynamics methods to investigate the diffusion of both intrinsic and extrinsic species in the HTL, including TBPH<sup>+</sup>, TFSI<sup>-</sup>, hydrogen iodide, and water. Our results, illustrated in Fig. 4B–E, show that the diffusion

coefficients ( $D$ ) of these species increase gradually with rising temperature. However, at a given temperature, the  $D$  values in the SBF-FC based HTL are lower than those observed in the spiro-OMeTAD congener.

In a thin film, the permeability ( $P$ ) of  $H_2O$  is positively correlated with its diffusion coefficient and solubility. Theoretical simulations reveal that when the weight percentage of TBPHTFSI is 15%, the  $P$  of  $H_2O$  in the SBF-FC based HTL is 0.046 Barrer, which is over eight times lower than the corresponding  $P$  (0.378 Barrer) of  $H_2O$  in the spiro-OMeTAD analogue (see Fig. 4F). To assess the water permeation through the HTL, we deposited the layer onto FAPbI<sub>3</sub> and dripped water droplets onto its surface. In the control experiment, a small water droplet on FAPbI<sub>3</sub> maintains an almost constant contact angle ( $\theta$ ) for 3 s, while the polarizing optical microscope (POM) image is already filled with birefringent yellow PbI<sub>2</sub> microcrystals (see Fig. 5A). After adding the HTL to the FAPbI<sub>3</sub> film, the  $\theta$  value significantly increases (see Fig. 5B and C). Specifically, the SBF-FC HTL shows a  $\theta$  of 92.4°, while that of the spiro-OMeTAD layer is 78.0°. The blocking effect of the HTL slows down the evolution of the POM image; however, water molecules can still permeate through it. We employed the Bohart–Adams model to fit the area ratio ( $\phi$ ) of the yellow region as a function of time (see Fig. 5D). The full degradation time constant of FAPbI<sub>3</sub> covered with the SBF-FC HTL is 153 s, which is significantly greater than that with the spiro-OMeTAD counterpart (17 s). The ratio (1 : 9) of the reciprocals of the full degradation time constant closely matches the ratio (1 : 8) of simulated  $P$  values. Both HTLs used here are 80 nm thick, and increasing the layer thickness results in a nearly linear increase of the full degradation time constant.

## 2.5 Application in perovskite solar cells

**2.5.1 Photovoltaic characteristics.** Using the HTLs containing 15% TBPHTFSI, we fabricated PSCs with the device architecture of ITO/SnO<sub>2</sub>/FAPbI<sub>3</sub>/HTL/Au, where ITO is indium tin oxide. The photocurrent density–voltage ( $J$ – $V$ ) curves of the PSCs were measured under simulated AM1.5G solar irradiation of 100 mW cm<sup>-2</sup>. For the details of cell fabrication and

characterization, please refer to the Experimental Section (ESI†). Fig. 6A–D present statistical distributions of four photovoltaic parameters, including short-circuit current density ( $J_{SC}$ ), open-circuit voltage ( $V_{OC}$ ), fill factor (FF), and power conversion efficiency (PCE). Compared with spiro-OMeTAD cells, SBF-FC cells exhibit higher  $V_{OC}$  and FF, resulting in higher PCE, while the difference in  $J_{SC}$  between the two types of cells is negligible. The  $J$ – $V$  characteristics of representative cells are displayed in Fig. 6E. The  $J_{SC}$  of the SBF-FC cell is 25.9 mA cm<sup>-2</sup>,  $V_{OC}$  is 1.180 V, FF is 0.809, and PCE is 24.7%, which is superior to the 22.9% PCE of the spiro-OMeTAD cell, with a  $J_{SC}$  of 25.9 mA cm<sup>-2</sup>,  $V_{OC}$  of 1.140 V, and FF of 0.776. Under the same conditions, the PSCs made with DM present lower efficiencies of 22.1% (Table 1) due to the low conductivity of the HTL, and is no longer of interest for further comparison. In addition, the external quantum efficiency (EQE) spectra of the cells under short-circuit conditions were obtained (Fig. S5A, ESI†), and the predicted short-circuit photo current densities ( $J_{SC}^{EQE}$ ) of the cells under AM1.5G conditions were computed in terms of the standard AM1.5G solar emission spectrum (Fig. S5B, ESI†). The  $J_{SC}^{EQE}$  values of both cells are approximately 24.9 mA cm<sup>-2</sup>, indicating that the mismatch factor of the used solar simulator is less than 5%.

To gain insight into the discrepancies observed in the  $V_{OC}$  and FF values, we utilized the Shockley diode equation<sup>44</sup> to perform numerical fitting of the  $J$ – $V$  data, as presented in Fig. 6E. Further simulations and analysis, outlined in Fig. S6 and Table S3 (ESI†), elucidate that the higher  $V_{OC}$  exhibited by the SBF-FC cell is a result of a smaller reverse saturation current ( $I_s$ ) and a larger shunt resistance ( $R_{sh}$ ), with the effect of  $I_s$  being more pronounced. Additionally, the higher FF displayed by the SBF-FC cell can be attributed to a combination of factors, including a smaller  $I_s$ , a smaller series resistance ( $R_s$ ), and a larger  $R_{sh}$ . The influences of these parameters on FF are ranked in the order  $I_s > R_s > R_{sh}$ . The smaller  $R_s$  is primarily associated with improved hole conduction of the HTL, while the larger  $R_{sh}$  is linked to slower charge recombination at the interface of the perovskite and HTL. The hole extraction study in Section 2.1 suggests that there is a weaker electronic wavefunction coupling between SBF-FC and the perovskite, which is consistent with the slower interface charge recombination. Moreover, scanning electron microscopy (SEM) images reveal that the spiro-OMeTAD layer on FAPbI<sub>3</sub> contains a small number of nanoscale pinholes (Fig. 6F), whereas SBF-FC forms a dense and uniform layer on FAPbI<sub>3</sub> (Fig. 6G). The pinholes may give rise to microdomain contact between the vacuum-deposited gold electrode and the perovskite, creating new charge recombination channels, which could also explain the larger  $I_s$  observed for the spiro-OMeTAD cell.

Subsequently, the maximum power point (MPP) tracking was performed on PSCs under simulated AM1.5G conditions. The temporal evolutions of power conversion efficiency at MPP (PCE<sub>MPP</sub>), current density at MPP ( $J_{MPP}$ ), and voltage at MPP ( $V_{MPP}$ ) are shown in Fig. 6H–J. Over 200 h, the PCE<sub>MPP</sub> of the SBF-FC cell decreases from an initial value of 24.3% to a final value of 21.6%, with a retention rate of 89%. The corresponding



**Fig. 5** (A–C) Temporal evolutions of the water contact angle ( $\theta$ ) and the polarized optical microscopy (POM) image upon dripping a water droplet on three samples: (A) FAPbI<sub>3</sub>, (B) spiro-OMeTAD covered FAPbI<sub>3</sub>, and (C) SBF-FC covered FAPbI<sub>3</sub>. The size of the POM image is 500  $\mu\text{m} \times$  250  $\mu\text{m}$ . In the yellow region, perovskite is decomposed. (D) Plots of the yellow region percentage ( $\phi$ ) as a function of time ( $t$ ).



**Fig. 6** (A–D) Box plots of photovoltaic parameters. (E) Current density–voltage ( $J$ – $V$ ) characteristics measured under AM1.5G conditions (dotted). The  $0.25\text{ cm}^2$  small cells were covered with a black metal mask with an aperture area of  $0.16\text{ cm}^2$  for measurements. The solid lines correspond to fits based on the Shockley diode equation. (F and G) Top-viewed SEM images of the hole transport layers of solar cells: (F) spiro-OMeTAD; (G) SBF-FC. Prior to measurement, the gold electrode underwent exfoliation. (H–J) Temporal evolutions of efficiency, current, and voltage during maximum power point tracking.

**Table 1** Photovoltaic parameters of fresh and aged PSCs<sup>a</sup>

Solar cell	$J_{sc}[\text{mA cm}^{-2}]$	$V_{oc}[\text{V}]$	FF[%]	PCE[%]
Spiro-OMeTAD	25.9	1.140	77.6	22.9
DM	25.9	1.190	71.6	22.1
SBF-FC	25.9	1.180	80.9	24.7
Spiro-OMeTAD/aged	13.3	0.715	43.2	4.2
SBF-FC/aged	25.2	1.160	77.3	22.6

<sup>a</sup> The photovoltaic parameters were measured under the AM1.5G conditions. The  $0.25\text{ cm}^2$  small cells were covered with a black metal mask with an aperture area of  $0.16\text{ cm}^2$  for measurements. The aging was carried out for 500 h at  $85\text{ }^\circ\text{C}$ .

$J_{MPP}$  and  $V_{MPP}$  exhibit retention rates of 95% and 94%, respectively. In contrast, the  $PCE_{MPP}$  of the spiro-OMeTAD cell decreases by 48% after only 40 hours. Numerical simulations of the  $J$ – $V$  curves before and after light aging reveal that aging causes an increase in  $R_s$  and a decrease in  $R_{sh}$ . The decrease in  $R_{sh}$  is indicative of an acceleration of charge recombination, which may be attributed to an increase in perovskite layer defects. The increase in  $R_s$  may also be associated with the increase in perovskite defects and scattering centers and the reduction in doping in the HTL caused by iodine species

migration. In Section 2.4, we have found that the diffusion coefficient of hydrogen iodide in the SBF-FC based HTL is indeed lower than that in spiro-OMeTAD control. Moreover, the degradation of the perovskite could also be influenced by species diffused from HTLs, such as  $TBPH^+$  and  $TFSI^-$ . Preliminary modelling has shown that the cohesive energy density of the SBF-FC/TBPH/TFSI composite is significantly higher than that of the spiro-OMeTAD counterpart, which should be relevant to the suppressed diffusion.

Thereby, we conclude that selecting an appropriate HTL to control species migration in PSCs is crucial for their practical operation.

**2.5.2 Cell stability at  $85\text{ }^\circ\text{C}$  and degradation analysis.** Unencapsulated PSCs were subjected to thermal aging at  $85\text{ }^\circ\text{C}$  and their  $J$ – $V$  characteristics were intermittently monitored under AM1.5G conditions. The evolution of PCE is shown in Fig. 7A, with decay observed primarily within the initial 24 h for both cells. After 500 h of aging, the SBF-FC cells exhibit a higher average PCE retention rate of 92% compared to the spiro-OMeTAD cells, which retain only 15% of the initial PCE. The  $J$ – $V$  curves of representative cells after 500 h of  $85\text{ }^\circ\text{C}$  aging are presented in Fig. S7 (ESI<sup>†</sup>), and detailed photovoltaic



**Fig. 7** (A) Temporal evolutions of the efficiency of solar cells aged at 85 °C. (B) External quantum efficiency spectra. (C and D) Cross-sectional SEM images of the solar cells after aging. (E and F) Top-view SEM images of the hole transport layer in the solar cells after aging. Prior to measurement, the gold electrode was exfoliated. (G and H) Top-view SEM images and (I and J) fluorescence optical microscopy images of the perovskite layer in the solar cells after aging. (K) Photoluminescence spectra of the solar cells before and after aging. Excitation wavelength: 375 nm. In panels G–K, the gold electrode and hole transport layer were removed prior to measurements. (L and M) Normalized X-ray diffraction patterns. Aging was carried out at 85 °C for 500 h.

parameters are listed in Table 1. The spiro-OMeTAD cell demonstrates significant decay in FF (44%),  $J_{SC}$  (48%), and  $V_{OC}$  (37%) after aging, while the decay rates for the SBF-FC cell are considerably lower at 4%, 3%, and 2%, respectively. The  $J_{SC}$  values of the cells before and after aging exhibit a linear relationship with the  $J_{SC}^{EQE}$  values, as shown in Fig. S8 (ESI†). Fig. 7B illustrates the impact of 500 h, 85 °C aging on the EQE maximum of the spiro-OMeTAD cell, which decreases from 94% to 56%. However, the decrease in the EQE maximum of the SBF-FC cell is relatively small, dropping from 94% to 91%.

Fig. 7C and D present the cross-sectional scanning electron microscopy (SEM) images of the aged PSCs. The spiro-OMeTAD based cell, after aging at 85 °C, exhibits significant damage to its perovskite layer compared to the SBF-FC cell. Notably, this phenomenon was not observed in PSCs prior to aging (Fig. S9, ESI†). We obtained top-view SEM topographies by removing the gold electrode of the aged PSCs, as shown in Fig. 7E and F. The spiro-OMeTAD based HTL displays numerous cracks after aging, while the SBF-FC counterpart remains intact. To examine the surface morphology of the perovskite layer of PSCs, we removed the HTL by spin-coating chlorobenzene and isopropanol. Prior to aging, the perovskite layer of PSCs exhibits a polycrystalline structure, with nanoparticles scattered on the surface of micrometer grains, as depicted in Fig. S10 (ESI†). In contrast, for the aged PSC with spiro-OMeTAD, the perovskite film shows intergranular cracks and voids, and some perovskite microcrystals display severe corrosion and/or decomposition (Fig. 7G). Meanwhile, the morphological degradation of the perovskite film is relatively insignificant for the aged PSC with SBF-FC (Fig. 7H). Prior to aging, no spatially resolved

microstructures were detected in the fluorescence optical microscopy images of the PSCs (Fig. S11, ESI†). However, after aging, a multitude of irregularly shaped  $PbI_2$  microparticles emitting green light were observed in the spiro-OMeTAD cell, as depicted in Fig. 7I. In contrast, a lower quantity of  $PbI_2$  microparticles was detected in the aged SBF-FC cell, as illustrated in Fig. 7J. The photoluminescence (PL) spectra of the PSCs before and after aging are presented in Fig. 7K. The full width at half maximum of the PL band centered at 808 nm remains consistent, irrespective of aging. The relatively weak PL band at 625 nm arises from the G-band emission of  $PbI_2$ . Prior to aging, the G-band emission of  $PbI_2$  is faint, implying that the perovskite film contains a low quantity of  $PbI_2$ . In contrast, for the aged PSCs, the G-band emission of  $PbI_2$  significantly intensifies, particularly in the spiro-OMeTAD cell. To evaluate the changes in X-ray diffraction of PSCs due to aging, we normalized the patterns using the diffraction peak of  $\alpha$ -FAPbI<sub>3</sub> as a reference (Fig. 7L and M). After aging, the intensity of the  $PbI_2$  diffraction peak increased by 16.7-fold for the spiro-OMeTAD cell, but only 1.2-fold for the SBF-FC cell.

### 3 Conclusions

In summary, we have developed a high glass transition temperature hole transport material, SBF-FC, by replacing the electron-donor dimethoxydiphenylamine of spirobifluorene with highly asymmetric trimethylated fluorenylcarbazolamine. When blended with an organic salt and processed through solution deposition, SBF-FC forms a thin film with excellent

hole conduction and a uniform morphology. By replacing the standard hole transport material spiro-OMeTAD with SBF-FC in the fabrication of FAPbI<sub>3</sub>-based PSCs, we have observed a substantial improvement in device efficiency. This is mainly attributed to enhancements in series resistance, shunt resistance, and reverse saturation current. Moreover, the SBF-FC hole transport layer exhibits reduced diffusion of intrinsic and extrinsic species and a durable morphology at 85 °C, which effectively suppress the corrosion and decomposition of the perovskite layer. The use of SBF-FC has enabled the fabrication of PSCs with an average efficiency of 24.5% and long-term thermostability at 85 °C. This study presents a promising approach for advancing the practical application of PSCs.

## Conflicts of interest

The authors declare no competing interests.

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